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#### [Understanding Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

#### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### **Details**

Product Status	Obsolete
Number of LABs/CLBs	768
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	81
Number of Gates	12000
Voltage - Supply	3V ~ 3.6V, 4.75V ~ 5.25V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 85°C (TA)
Package / Case	100-TQFP
Supplier Device Package	100-VQFP (14x14)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microsemi/a54sx08-vq100i">https://www.e-xfl.com/product-detail/microsemi/a54sx08-vq100i</a>

## Chip Architecture

The SX family chip architecture provides a unique approach to module organization and chip routing that delivers the best register/logic mix for a wide variety of new and emerging applications.

## Module Organization

Actel has arranged all C-cell and R-cell logic modules into horizontal banks called *clusters*. There are two types of *clusters*: Type 1 contains two C-cells and one R-cell, while Type 2 contains one C-cell and two R-cells.

To increase design efficiency and device performance, Actel has further organized these modules into *SuperClusters* (Figure 1-4). SuperCluster 1 is a two-wide grouping of Type 1 clusters. SuperCluster 2 is a two-wide group containing one Type 1 cluster and one Type 2 cluster. SX devices feature more SuperCluster 1 modules than SuperCluster 2 modules because designers typically require significantly more combinatorial logic than flip-flops.

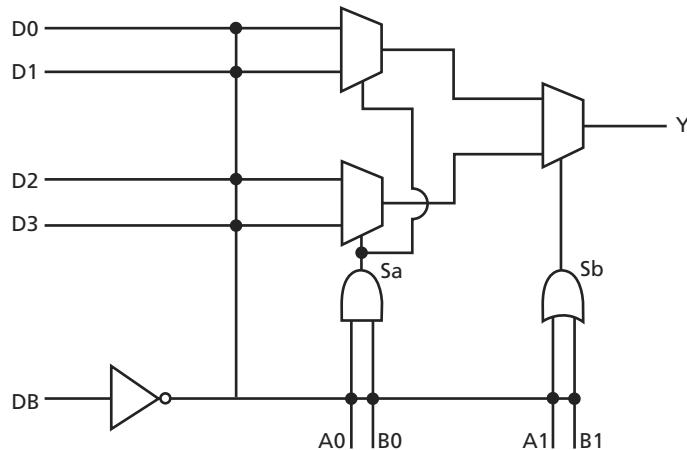


Figure 1-3 • C-Cell

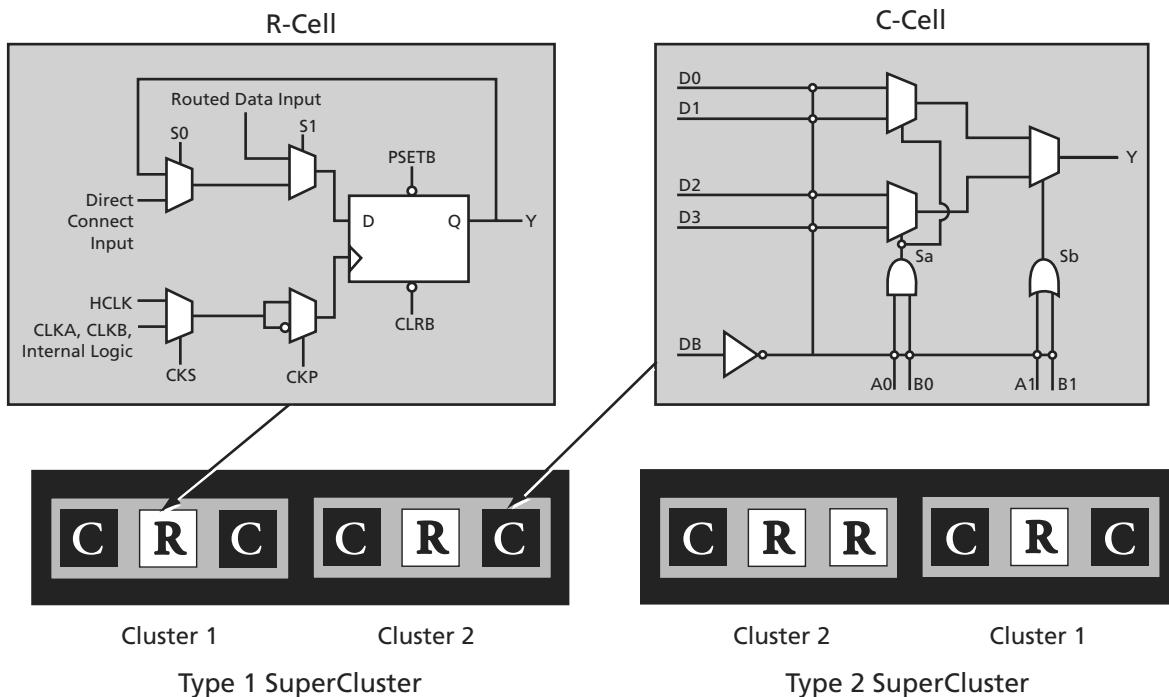


Figure 1-4 • Cluster Organization

DirectConnect is a horizontal routing resource that provides connections from a C-cell to its neighboring R-cell in a given SuperCluster. DirectConnect uses a hardwired signal path requiring no programmable interconnection to achieve its fast signal propagation time of less than 0.1 ns.

FastConnect enables horizontal routing between any two logic modules within a given SuperCluster and vertical routing with the SuperCluster immediately below it. Only one programmable connection is used in a FastConnect path, delivering maximum pin-to-pin propagation of 0.4 ns.

In addition to DirectConnect and FastConnect, the architecture makes use of two globally oriented routing resources known as segmented routing and high-drive routing. The Actel segmented routing structure provides a variety of track lengths for extremely fast routing between SuperClusters. The exact combination of track lengths and antifuses within each path is chosen by the 100 percent automatic place-and-route software to minimize signal propagation delays.

The Actel high-drive routing structure provides three clock networks. The first clock, called HCLK, is hardwired from the HCLK buffer to the clock select multiplexer (MUX) in each R-cell. This provides a fast propagation path for the clock signal, enabling the 3.7 ns clock-to-out (pin-to-pin) performance of the SX devices. The hardwired clock is tuned to provide clock skew as low as 0.25 ns. The remaining two clocks (CLKA, CLKB) are global clocks that can be sourced from external pins or from internal logic signals within the SX device.

## Other Architectural Features

### Technology

The Actel SX family is implemented on a high-voltage twin-well CMOS process using 0.35  $\mu$  design rules. The metal-to-metal antifuse is made up of a combination of amorphous silicon and dielectric material with barrier metals and has a programmed ("on" state) resistance of 25  $\Omega$  with a capacitance of 1.0 fF for low signal impedance.

### Performance

The combination of architectural features described above enables SX devices to operate with internal clock frequencies exceeding 300 MHz, enabling very fast execution of even complex logic functions. Thus, the SX family is an optimal platform upon which to integrate the functionality previously contained in multiple CPLDs. In addition, designs that previously would have required a gate array to meet performance goals can now be integrated into an SX device with dramatic improvements in cost and time to market. Using timing-driven place-and-route tools, designers can achieve highly deterministic device performance. With SX devices, designers do not need to use complicated performance-enhancing design techniques such as the use of redundant logic to reduce fanout on critical nets or the instantiation of macros in HDL code to achieve high performance.

### I/O Modules

Each I/O on an SX device can be configured as an input, an output, a tristate output, or a bidirectional pin.

Even without the inclusion of dedicated I/O registers, these I/Os, in combination with array registers, can achieve clock-to-out (pad-to-pad) timing as fast as 3.7 ns. I/O cells that have embedded latches and flip-flops require instantiation in HDL code; this is a design complication not encountered in SX FPGAs. Fast pin-to-pin timing ensures that the device will have little trouble interfacing with any other device in the system, which in turn enables parallel design of system components and reduces overall design time.

### Power Requirements

The SX family supports 3.3 V operation and is designed to tolerate 5.0 V inputs. (Table 1-1). Power consumption is extremely low due to the very short distances signals are required to travel to complete a circuit. Power requirements are further reduced because of the small number of low-resistance antifuses in the path. The antifuse architecture does not require active circuitry to hold a charge (as do SRAM or EPROM), making it the lowest power architecture on the market.

**Table 1-1 • Supply Voltages**

<b>Device</b>	<b>V<sub>CCA</sub></b>	<b>V<sub>CCI</sub></b>	<b>V<sub>CCR</sub></b>	<b>Maximum Input Tolerance</b>	<b>Maximum Output Drive</b>
A54SX08	3.3 V	3.3 V	5.0 V	5.0 V	3.3 V
A54SX16					
A54SX32					
A54SX16-P*	3.3 V	3.3 V	3.3 V	3.3 V	3.3 V
	3.3 V	3.3 V	5.0 V	5.0 V	3.3 V
	3.3 V	5.0 V	5.0 V	5.0 V	5.0 V

**Note:** \*A54SX16-P has three different entries because it is capable of both a 3.3 V and a 5.0 V drive.

Table 1-4 • Recommended Operating Conditions

Parameter	Commercial	Industrial	Military	Units
Temperature Range*	0 to + 70	-40 to + 85	-55 to +125	°C
3.3 V Power Supply Tolerance	±10	±10	±10	%V <sub>CC</sub>
5.0 V Power Supply Tolerance	±5	±10	±10	%V <sub>CC</sub>

Note: \*Ambient temperature ( $T_A$ ) is used for commercial and industrial; case temperature ( $T_C$ ) is used for military.

Table 1-5 • Electrical Specifications

Symbol	Parameter	Commercial		Industrial		Units
		Min.	Max.	Min.	Max.	
V <sub>OH</sub>	(I <sub>OH</sub> = -20 µA) (CMOS) (I <sub>OH</sub> = -8 mA) (TTL) (I <sub>OH</sub> = -6 mA) (TTL)	(V <sub>CCI</sub> - 0.1) 2.4	V <sub>CCI</sub> V <sub>CCI</sub>	(V <sub>CCI</sub> - 0.1) 2.4	V <sub>CCI</sub> V <sub>CCI</sub>	V
V <sub>OL</sub>	(I <sub>OL</sub> = 20 µA) (CMOS) (I <sub>OL</sub> = 12 mA) (TTL) (I <sub>OL</sub> = 8 mA) (TTL)		0.10 0.50		0.50	V
V <sub>IL</sub>			0.8		0.8	V
V <sub>IH</sub>		2.0		2.0		V
t <sub>R</sub> , t <sub>F</sub>	Input Transition Time t <sub>R</sub> , t <sub>F</sub>		50		50	ns
C <sub>IO</sub>	C <sub>IO</sub> I/O Capacitance		10		10	pF
I <sub>CC</sub>	Standby Current, I <sub>CC</sub>		4.0		4.0	mA
I <sub>CC(D)</sub>	I <sub>CC(D)</sub> I <sub>Dynamic</sub> V <sub>CC</sub> Supply Current	See "Evaluating Power in SX Devices" on page 1-16.				

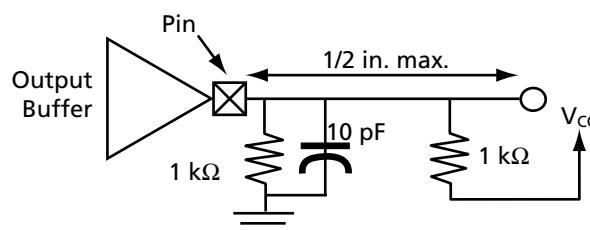
## A54SX16P AC Specifications (3.3 V PCI Operation)

Table 1-9 • A54SX16P AC Specifications (3.3 V PCI Operation)

<b>Symbol</b>	<b>Parameter</b>	<b>Condition</b>	<b>Min.</b>	<b>Max.</b>	<b>Units</b>
$I_{OH(AC)}$	Switching Current High	$0 < V_{OUT} \leq 0.3V_{CC}$ <sup>1</sup>			mA
		$0.3V_{CC} \leq V_{OUT} < 0.9V_{CC}$ <sup>1</sup>	-12 $V_{CC}$		mA
		$0.7V_{CC} < V_{OUT} < V_{CC}$ <sup>1, 2</sup>	-17.1 + ( $V_{CC} - V_{OUT}$ )	EQ 1-3 on page 1-14	
	(Test Point)	$V_{OUT} = 0.7V_{CC}$ <sup>2</sup>		-32 $V_{CC}$	mA
$I_{OL(AC)}$	Switching Current High	$V_{CC} > V_{OUT} \geq 0.6V_{CC}$ <sup>1</sup>			mA
		$0.6V_{CC} > V_{OUT} > 0.1V_{CC}$ <sup>1</sup>	16 $V_{CC}$		mA
		$0.18V_{CC} > V_{OUT} > 0$ <sup>1, 2</sup>	26.7 $V_{OUT}$	EQ 1-4 on page 1-14	mA
	(Test Point)	$V_{OUT} = 0.18V_{CC}$ <sup>2</sup>		38 $V_{CC}$	
$I_{CL}$	Low Clamp Current	$-3 < V_{IN} \leq -1$	-25 + ( $V_{IN} + 1$ )/0.015		mA
$I_{CH}$	High Clamp Current	$-3 < V_{IN} \leq -1$	25 + ( $V_{IN} - V_{OUT} - 1$ )/0.015		mA
slew <sub>R</sub>	Output Rise Slew Rate <sup>3</sup>	0.2 $V_{CC}$ to 0.6 $V_{CC}$ load	1	4	V/ns
slew <sub>F</sub>	Output Fall Slew Rate <sup>3</sup>	0.6 $V_{CC}$ to 0.2 $V_{CC}$ load	1	4	V/ns

**Notes:**

1. Refer to the  $V/I$  curves in Figure 1-10 on page 1-14. Switching current characteristics for REQ# and GNT# are permitted to be one half of that specified here; i.e., half size output drivers may be used on these signals. This specification does not apply to CLK and RST# which are system outputs. "Switching Current High" specification are not relevant to SERR#, INTA#, INTB#, INTC#, and INTD# which are open drain outputs.
2. Maximum current requirements must be met as drivers pull beyond the last step voltage. Equations defining these maximums (C and D) are provided with the respective diagrams in Figure 1-10 on page 1-14. The equation defined maxima should be met by design. In order to facilitate component testing, a maximum current test point is defined for each side of the output driver.
3. This parameter is to be interpreted as the cumulative edge rate across the specified range, rather than the instantaneous rate at any point within the transition range. The specified load (diagram below) is optional; i.e., the designer may elect to meet this parameter with an unloaded output per the latest revision of the PCI Local Bus Specification. However, adherence to both maximum and minimum parameters is required (the maximum is no longer simply a guideline). Rise slew rate does not apply to open drain outputs.



## Power-Up Sequencing

Table 1-10 • Power-Up Sequencing

<b>V<sub>CCA</sub></b>	<b>V<sub>CCR</sub></b>	<b>V<sub>CCI</sub></b>	<b>Power-Up Sequence</b>	<b>Comments</b>
<b>A54SX08, A54SX16, A54SX32</b>				
3.3 V	5.0 V	3.3 V	5.0 V First 3.3 V Second	No possible damage to device
			3.3 V First 5.0 V Second	Possible damage to device
<b>A54SX16P</b>				
3.3 V	3.3 V	3.3 V	3.3 V Only	No possible damage to device
3.3 V	5.0 V	3.3 V	5.0 V First 3.3 V Second	No possible damage to device
			3.3 V First 5.0 V Second	Possible damage to device
3.3 V	5.0 V	5.0 V	5.0 V First 3.3 V Second	No possible damage to device
			3.3 V First 5.0 V Second	No possible damage to device

**Note:** No inputs should be driven (high or low) before completion of power-up.

## Power-Down Sequencing

Table 1-11 • Power-Down Sequencing

<b>V<sub>CCA</sub></b>	<b>V<sub>CCR</sub></b>	<b>V<sub>CCI</sub></b>	<b>Power-Down Sequence</b>	<b>Comments</b>
<b>A54SX08, A54SX16, A54SX32</b>				
3.3 V	5.0 V	3.3 V	5.0 V First 3.3 V Second	Possible damage to device
			3.3 V First 5.0 V Second	No possible damage to device
<b>A54SX16P</b>				
3.3 V	3.3 V	3.3 V	3.3 V Only	No possible damage to device
3.3 V	5.0 V	3.3 V	5.0 V First 3.3 V Second	Possible damage to device
			3.3 V First 5.0 V Second	No possible damage to device
3.3 V	5.0 V	5.0 V	5.0 V First 3.3 V Second	No possible damage to device
			3.3 V First 5.0 V Second	No possible damage to device

**Note:** No inputs should be driven (high or low) after the beginning of the power-down sequence.

**Step 1: Define Terms Used in Formula**

<b>Module</b>	V <sub>CCA</sub>	3.3
Number of logic modules switching at f <sub>m</sub> (Used 50%)	m	264
Average logic modules switching rate f <sub>m</sub> (MHz) (Guidelines: f/10)	f <sub>m</sub>	20
Module capacitance C <sub>EQM</sub> (pF)	C <sub>EQM</sub>	4.0
<b>Input Buffer</b>		
Number of input buffers switching at f <sub>n</sub>	n	1
Average input switching rate f <sub>n</sub> (MHz) (Guidelines: f/5)	f <sub>n</sub>	40
Input buffer capacitance C <sub>EQI</sub> (pF)	C <sub>EQI</sub>	3.4
<b>Output Buffer</b>		
Number of output buffers switching at f <sub>p</sub>	p	1
Average output buffers switching rate f <sub>p</sub> (MHz) (Guidelines: f/10)	f <sub>p</sub>	20
Output buffers buffer capacitance C <sub>EQO</sub> (pF)	C <sub>EQO</sub>	4.7
Output Load capacitance C <sub>L</sub> (pF)	C <sub>L</sub>	35
<b>RCLKA</b>		
Number of Clock loads q <sub>1</sub>	q <sub>1</sub>	528
Capacitance of routed array clock (pF)	C <sub>EQCR</sub>	1.6
Average clock rate (MHz)	f <sub>q1</sub>	200
Fixed capacitance (pF)	r <sub>1</sub>	138
<b>RCLKB</b>		
Number of Clock loads q <sub>2</sub>	q <sub>2</sub>	0
Capacitance of routed array clock (pF)	C <sub>EQCR</sub>	1.6
Average clock rate (MHz)	f <sub>q2</sub>	0
Fixed capacitance (pF)	r <sub>2</sub>	138
<b>HCLK</b>		
Number of Clock loads	s <sub>1</sub>	0
Variable capacitance of dedicated array clock (pF)	C <sub>EQHV</sub>	0.615
Fixed capacitance of dedicated array clock (pF)	C <sub>EQHF</sub>	96
Average clock rate (MHz)	f <sub>s1</sub>	0

**Step 2: Calculate Dynamic Power Consumption**

V <sub>CCA</sub> × V <sub>CCA</sub>	10.89
m × f <sub>m</sub> × C <sub>EQM</sub>	0.02112
n × f <sub>n</sub> × C <sub>EQI</sub>	0.000136
p × f <sub>p</sub> × (C <sub>EQO</sub> +C <sub>L</sub> )	0.000794
0.5 (q <sub>1</sub> × C <sub>EQCR</sub> × f <sub>q1</sub> ) + (r <sub>1</sub> × f <sub>q1</sub> )	0.11208
0.5(q <sub>2</sub> × C <sub>EQCR</sub> × f <sub>q2</sub> ) + (r <sub>2</sub> × f <sub>q2</sub> )	0
0.5 (s <sub>1</sub> × C <sub>EQHV</sub> × f <sub>s1</sub> ) + (C <sub>EQHF</sub> × f <sub>s1</sub> )	0
P <sub>AC</sub> = 1.461 W	

**Step 3: Calculate DC Power Dissipation****DC Power Dissipation**

$$P_{DC} = (I_{standby}) \times V_{CCA} + (I_{standby}) \times V_{CCR} + (I_{standby}) \times V_{CCI} + X \times V_{OL} \times I_{OL} + Y(V_{CCI} - V_{OH}) \times V_{OH}$$

EQ 1-12

For a rough estimate of DC Power Dissipation, only use P<sub>DC</sub> = (I<sub>standby</sub>) × V<sub>CCA</sub>. The rest of the formula provides a very small number that can be considered negligible.

$$P_{DC} = (I_{standby}) \times V_{CCA}$$

$$P_{DC} = .55 \text{ mA} \times 3.3 \text{ V}$$

$$P_{DC} = 0.001815 \text{ W}$$

**Step 4: Calculate Total Power Consumption**

$$P_{Total} = P_{AC} + P_{DC}$$

$$P_{Total} = 1.461 + 0.001815$$

$$P_{Total} = 1.4628 \text{ W}$$

**Step 5: Compare Estimated Power Consumption against Characterized Power Consumption**

The estimated total power consumption for this design is 1.46 W. The characterized power consumption for this design at 200 MHz is 1.0164 W.

Figure 1-11 shows the characterized power dissipation numbers for the shift register design using frequencies ranging from 1 MHz to 200 MHz.

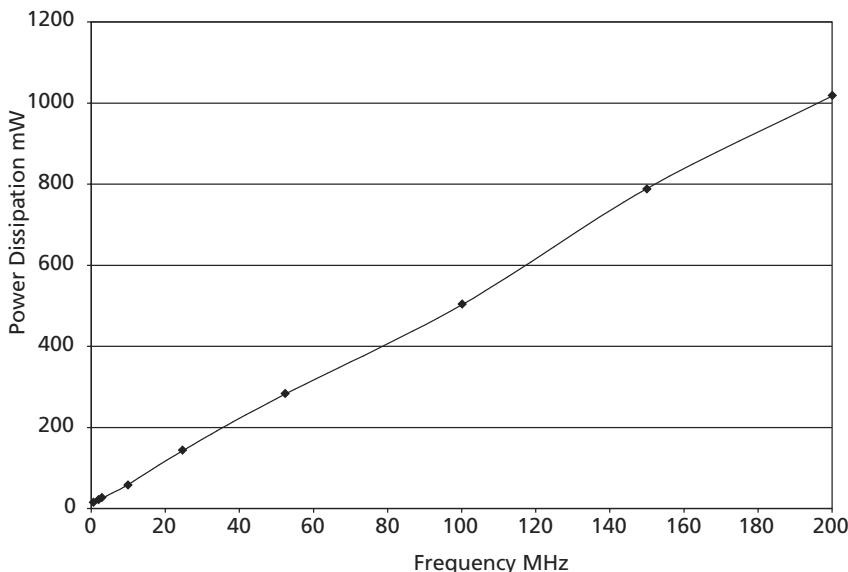


Figure 1-11 • Power Dissipation

## Junction Temperature ( $T_j$ )

The temperature that you select in Designer Series software is the junction temperature, not ambient temperature. This is an important distinction because the heat generated from dynamic power consumption is usually hotter than the ambient temperature. Use the equation below to calculate junction temperature.

$$\text{Junction Temperature} = \Delta T + T_a \quad EQ\ 1-13$$

Where:

$T_a$  = Ambient Temperature

$\Delta T$  = Temperature gradient between junction (silicon) and ambient

$$\Delta T = \theta_{ja} \times P$$

$P$  = Power calculated from Estimating Power Consumption section

$\theta_{ja}$  = Junction to ambient of package.  $\theta_{ja}$  numbers are located in the "Package Thermal Characteristics" section.

## Package Thermal Characteristics

The device junction to case thermal characteristic is  $\theta_{jc}$ , and the junction to ambient air characteristic is  $\theta_{ja}$ . The thermal characteristics for  $\theta_{ja}$  are shown with two different air flow rates.

The maximum junction temperature is 150 °C.

A sample calculation of the absolute maximum power dissipation allowed for a TQFP 176-pin package at commercial temperature and still air is as follows:

$$\text{Maximum Power Allowed} = \frac{\text{Max. junction temp. (°C)} - \text{Max. ambient temp. (°C)}}{\theta_{ja} (\text{°C/W})} = \frac{150^\circ\text{C} - 70^\circ\text{C}}{28^\circ\text{C/W}} = 2.86 \text{ W}$$

EQ 1-14

## A54SX08 Timing Characteristics

Table 1-17 • A54SX08 Timing Characteristics  
(Worst-Case Commercial Conditions,  $V_{CCR} = 4.75$  V,  $V_{CCA}, V_{CCI} = 3.0$  V,  $T_J = 70^\circ\text{C}$ )

<b>Parameter</b>	<b>Description</b>	'-3' Speed		'-2' Speed		'-1' Speed		'Std' Speed		<b>Units</b>
		<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	<b>Min.</b>	<b>Max.</b>	
<b>C-Cell Propagation Delays<sup>1</sup></b>										
$t_{PD}$	Internal Array Module	0.6		0.7		0.8		0.9		ns
<b>Predicted Routing Delays<sup>2</sup></b>										
$t_{RD1}$	FO = 1 Routing Delay, Direct Connect	0.1		0.1		0.1		0.1		ns
$t_{RD2}$	FO = 1 Routing Delay, Fast Connect	0.3		0.4		0.4		0.5		ns
$t_{RD3}$	FO = 1 Routing Delay	0.3		0.4		0.4		0.5		ns
$t_{RD4}$	FO = 2 Routing Delay	0.6		0.7		0.8		0.9		ns
$t_{RD8}$	FO = 3 Routing Delay	0.8		0.9		1.0		1.2		ns
$t_{RD12}$	FO = 4 Routing Delay	1.0		1.2		1.4		1.6		ns
$t_{RD16}$	FO = 8 Routing Delay	1.9		2.2		2.5		2.9		ns
$t_{RD32}$	FO = 12 Routing Delay	2.8		3.2		3.7		4.3		ns
<b>R-Cell Timing</b>										
$t_{RCO}$	Sequential Clock-to-Q	0.8		1.1		1.2		1.4		ns
$t_{CLR}$	Asynchronous Clear-to-Q	0.5		0.6		0.7		0.8		ns
$t_{PRESET}$	Asynchronous Preset-to-Q	0.7		0.8		0.9		1.0		ns
$t_{SUD}$	Flip-Flop Data Input Set-Up	0.5		0.5		0.7		0.8		ns
$t_{HD}$	Flip-Flop Data Input Hold	0.0		0.0		0.0		0.0		ns
$t_{WASYN}$	Asynchronous Pulse Width	1.4		1.6		1.8		2.1		ns
<b>Input Module Propagation Delays</b>										
$t_{INYH}$	Input Data Pad-to-Y HIGH	1.5		1.7		1.9		2.2		ns
$t_{INYL}$	Input Data Pad-to-Y LOW	1.5		1.7		1.9		2.2		ns
<b>Input Module Predicted Routing Delays<sup>2</sup></b>										
$t_{IRD1}$	FO = 1 Routing Delay	0.3		0.4		0.4		0.5		ns
$t_{IRD2}$	FO = 2 Routing Delay	0.6		0.7		0.8		0.9		ns
$t_{IRD3}$	FO = 3 Routing Delay	0.8		0.9		1.0		1.2		ns
$t_{IRD4}$	FO = 4 Routing Delay	1.0		1.2		1.4		1.6		ns
$t_{IRD8}$	FO = 8 Routing Delay	1.9		2.2		2.5		2.9		ns
$t_{IRD12}$	FO = 12 Routing Delay	2.8		3.2		3.7		4.3		ns

**Note:**

- For dual-module macros, use  $t_{PD} + t_{RD1} + t_{PDn}$ ,  $t_{RCO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.

Table 1-19 • A54SX16P Timing Characteristics (Continued)  
(Worst-Case Commercial Conditions,  $V_{CCR} = 4.75$  V,  $V_{CCA}, V_{CCI} = 3.0$  V,  $T_J = 70^\circ\text{C}$ )

<b>Parameter</b>	<b>Description</b>	'-3' Speed		'-2' Speed		'-1' Speed		'Std' Speed		<b>Units</b>
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>TTL/PCI Output Module Timing</b>										
$t_{DLH}$	Data-to-Pad LOW to HIGH	1.5		1.7		2.0		2.3		ns
$t_{DHL}$	Data-to-Pad HIGH to LOW		1.9		2.2		2.4		2.9	ns
$t_{ENLZ}$	Enable-to-Pad, Z to L		2.3		2.6		3.0		3.5	ns
$t_{ENZH}$	Enable-to-Pad, Z to H		1.5		1.7		1.9		2.3	ns
$t_{ENLZ}$	Enable-to-Pad, L to Z		2.7		3.1		3.5		4.1	ns
$t_{ENHZ}$	Enable-to-Pad, H to Z		2.9		3.3		3.7		4.4	ns
<b>PCI Output Module Timing<sup>3</sup></b>										
$t_{DLH}$	Data-to-Pad LOW to HIGH	1.8		2.0		2.3		2.7		ns
$t_{DHL}$	Data-to-Pad HIGH to LOW		1.7		2.0		2.2		2.6	ns
$t_{ENLZ}$	Enable-to-Pad, Z to L		0.8		1.0		1.1		1.3	ns
$t_{ENZH}$	Enable-to-Pad, Z to H		1.2		1.2		1.5		1.8	ns
$t_{ENLZ}$	Enable-to-Pad, L to Z		1.0		1.1		1.3		1.5	ns
$t_{ENHZ}$	Enable-to-Pad, H to Z		1.1		1.3		1.5		1.7	ns
<b>TTL Output Module Timing</b>										
$t_{DLH}$	Data-to-Pad LOW to HIGH	2.1		2.5		2.8		3.3		ns
$t_{DHL}$	Data-to-Pad HIGH to LOW		2.0		2.3		2.6		3.1	ns
$t_{ENLZ}$	Enable-to-Pad, Z to L		2.5		2.9		3.2		3.8	ns
$t_{ENZH}$	Enable-to-Pad, Z to H		3.0		3.5		3.9		4.6	ns
$t_{ENLZ}$	Enable-to-Pad, L to Z		2.3		2.7		3.1		3.6	ns
$t_{ENHZ}$	Enable-to-Pad, H to Z		2.9		3.3		3.7		4.4	ns

**Note:**

- For dual-module macros, use  $t_{PD} + t_{RD1} + t_{PDn}$ ,  $t_{RCO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.
- Delays based on 10 pF loading.

Table 1-20 • A54SX32 Timing Characteristics (Continued)  
(Worst-Case Commercial Conditions,  $V_{CCR} = 4.75$  V,  $V_{CCA}, V_{CCI} = 3.0$  V,  $T_J = 70^\circ\text{C}$ )

<b>Parameter</b>	<b>Description</b>	'-3' Speed		'-2' Speed		'-1' Speed		'Std' Speed		<b>Units</b>
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
<b>Dedicated (Hardwired) Array Clock Network</b>										
$t_{HCKH}$	Input LOW to HIGH (pad to R-Cell input)		1.9		2.1		2.4		2.8	ns
$t_{HCKL}$	Input HIGH to LOW (pad to R-Cell input)		1.9		2.1		2.4		2.8	ns
$t_{HPWH}$	Minimum Pulse Width HIGH	1.4		1.6		1.8		2.1		ns
$t_{HPWL}$	Minimum Pulse Width LOW	1.4		1.6		1.8		2.1		ns
$t_{HCKSW}$	Maximum Skew		0.3		0.4		0.4		0.5	ns
$t_{HP}$	Minimum Period	2.7		3.1		3.6		4.2		ns
$f_{HMAX}$	Maximum Frequency		350		320		280		240	MHz
<b>Routed Array Clock Networks</b>										
$t_{RCKH}$	Input LOW to HIGH (light load) (pad to R-Cell input)		2.4		2.7		3.0		3.5	ns
$t_{RCKL}$	Input HIGH to LOW (light load) (pad to R-Cell input)		2.4		2.7		3.1		3.6	ns
$t_{RCKH}$	Input LOW to HIGH (50% load) (pad to R-Cell input)		2.7		3.0		3.5		4.1	ns
$t_{RCKL}$	Input HIGH to LOW (50% load) (pad to R-Cell input)		2.7		3.1		3.6		4.2	ns
$t_{RCKH}$	Input LOW to HIGH (100% load) (pad to R-Cell input)		2.7		3.1		3.5		4.1	ns
$t_{RCKL}$	Input HIGH to LOW (100% load) (pad to R-Cell input)		2.8		3.2		3.6		4.3	ns
$t_{RPWH}$	Min. Pulse Width HIGH	2.1		2.4		2.7		3.2		ns
$t_{RPWL}$	Min. Pulse Width LOW	2.1		2.4		2.7		3.2		ns
$t_{RCKSW}$	Maximum Skew (light load)		0.85		0.98		1.1		1.3	ns
$t_{RCKSW}$	Maximum Skew (50% load)		1.23		1.4		1.6		1.9	ns
$t_{RCKSW}$	Maximum Skew (100% load)		1.30		1.5		1.7		2.0	ns
<b>TTL Output Module Timing<sup>3</sup></b>										
$t_{DLH}$	Data-to-Pad LOW to HIGH		1.6		1.9		2.1		2.5	ns
$t_{DHL}$	Data-to-Pad HIGH to LOW		1.6		1.9		2.1		2.5	ns
$t_{ENZL}$	Enable-to-Pad, Z to L		2.1		2.4		2.8		3.2	ns
$t_{ENZH}$	Enable-to-Pad, Z to H		2.3		2.7		3.1		3.6	ns
$t_{ENLZ}$	Enable-to-Pad, L to Z		1.4		1.7		1.9		2.2	ns
$t_{ENHZ}$	Enable-to-Pad, H to Z		1.3		1.5		1.7		2.0	ns

**Note:**

- For dual-module macros, use  $t_{PD} + t_{RD1} + t_{PDn}$ ,  $t_{RCO} + t_{RD1} + t_{PDn}$ , or  $t_{PD1} + t_{RD1} + t_{SUD}$ , whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual worst-case performance. Post-route timing is based on actual routing delay measurements performed on the device prior to shipment.
- Delays based on 35 pF loading, except  $t_{ENLZ}$  and  $t_{ENZH}$ . For  $t_{ENLZ}$  and  $t_{ENZH}$  the loading is 5 pF.

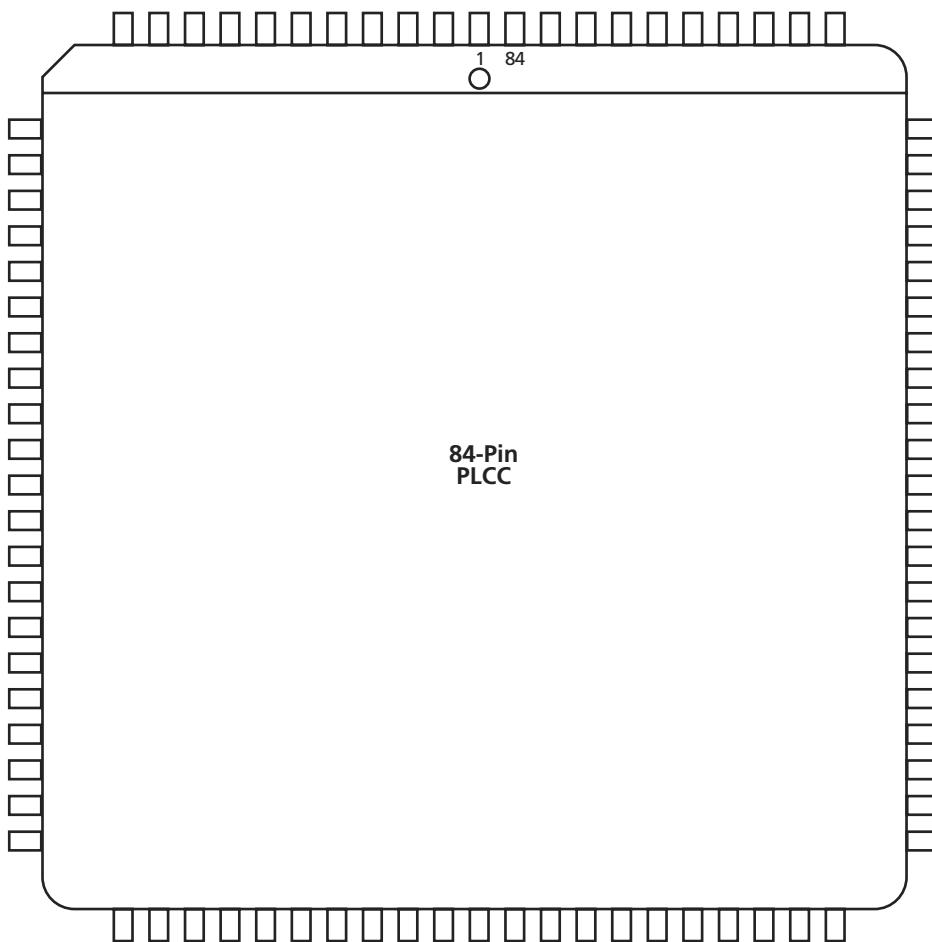
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# Package Pin Assignments

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## 84-Pin PLCC

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Figure 2-1 • 84-Pin PLCC (Top View)

### Note

For Package Manufacturing and Environmental information, visit the Package Resource center at <http://www.actel.com/products/rescenter/package/index.html>.

## 208-Pin PQFP

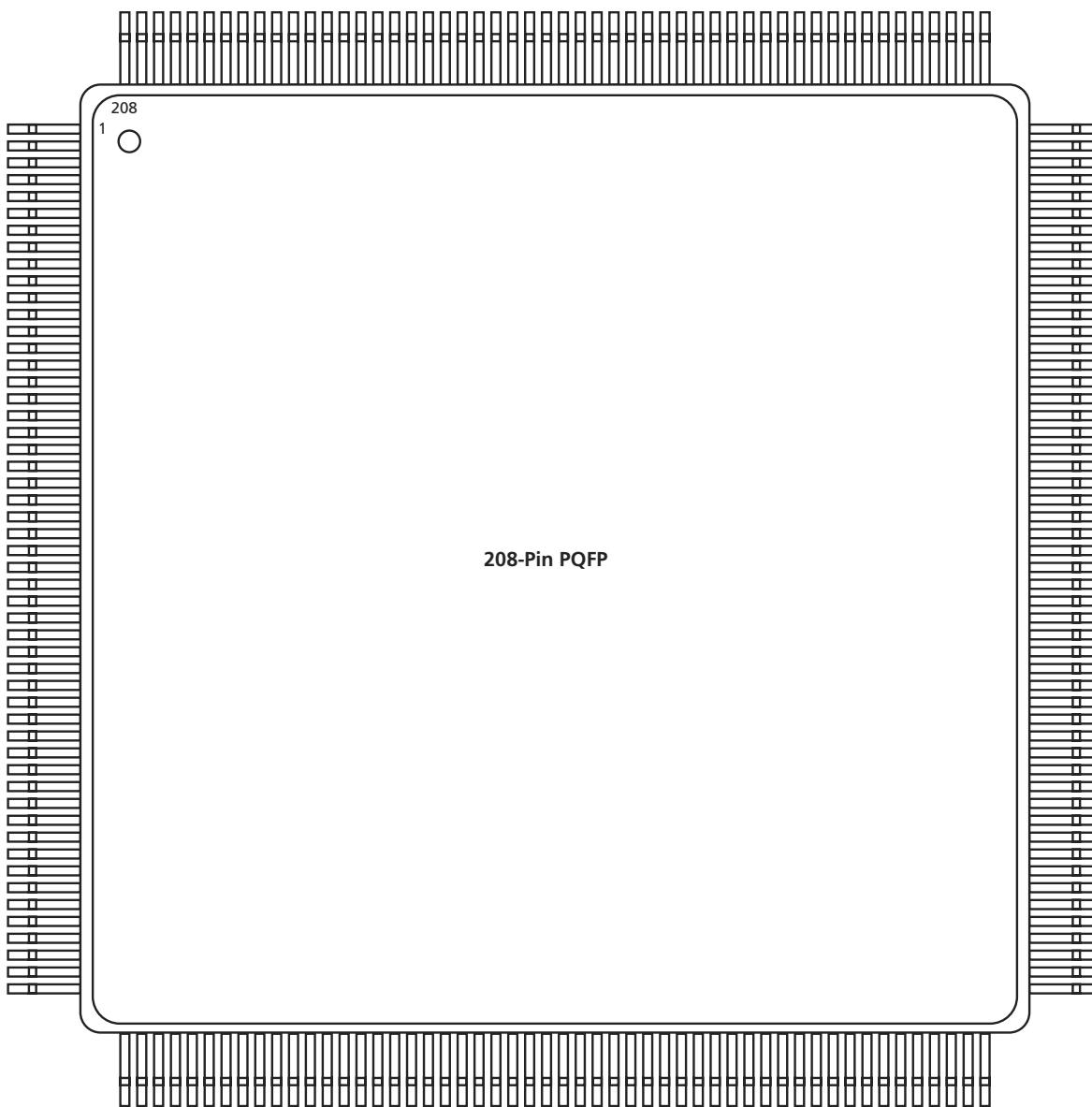


Figure 2-2 • 208-Pin PQFP (Top View)

### Note

For Package Manufacturing and Environmental information, visit the Package Resource center at <http://www.actel.com/products/rescenter/package/index.html>.

<b>208-Pin PQFP</b>			
<b>Pin Number</b>	<b>A54SX08 Function</b>	<b>A54SX16, A54SX16P Function</b>	<b>A54SX32 Function</b>
1	GND	GND	GND
2	TDI, I/O	TDI, I/O	TDI, I/O
3	I/O	I/O	I/O
4	NC	I/O	I/O
5	I/O	I/O	I/O
6	NC	I/O	I/O
7	I/O	I/O	I/O
8	I/O	I/O	I/O
9	I/O	I/O	I/O
10	I/O	I/O	I/O
11	TMS	TMS	TMS
12	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
13	I/O	I/O	I/O
14	NC	I/O	I/O
15	I/O	I/O	I/O
16	I/O	I/O	I/O
17	NC	I/O	I/O
18	I/O	I/O	I/O
19	I/O	I/O	I/O
20	NC	I/O	I/O
21	I/O	I/O	I/O
22	I/O	I/O	I/O
23	NC	I/O	I/O
24	I/O	I/O	I/O
25	V <sub>CCR</sub>	V <sub>CCR</sub>	V <sub>CCR</sub>
26	GND	GND	GND
27	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
28	GND	GND	GND
29	I/O	I/O	I/O
30	I/O	I/O	I/O
31	NC	I/O	I/O
32	I/O	I/O	I/O
33	I/O	I/O	I/O
34	I/O	I/O	I/O
35	NC	I/O	I/O
36	I/O	I/O	I/O

**Note:** \* Note that Pin 65 in the A54SX32—PQ208 is a no connect (NC).

<b>208-Pin PQFP</b>			
<b>Pin Number</b>	<b>A54SX08 Function</b>	<b>A54SX16, A54SX16P Function</b>	<b>A54SX32 Function</b>
37	I/O	I/O	I/O
38	I/O	I/O	I/O
39	NC	I/O	I/O
40	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
41	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
42	I/O	I/O	I/O
43	I/O	I/O	I/O
44	I/O	I/O	I/O
45	I/O	I/O	I/O
46	I/O	I/O	I/O
47	I/O	I/O	I/O
48	NC	I/O	I/O
49	I/O	I/O	I/O
50	NC	I/O	I/O
51	I/O	I/O	I/O
52	GND	GND	GND
53	I/O	I/O	I/O
54	I/O	I/O	I/O
55	I/O	I/O	I/O
56	I/O	I/O	I/O
57	I/O	I/O	I/O
58	I/O	I/O	I/O
59	I/O	I/O	I/O
60	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
61	NC	I/O	I/O
62	I/O	I/O	I/O
63	I/O	I/O	I/O
64	NC	I/O	I/O
65*	I/O	I/O	NC*
66	I/O	I/O	I/O
67	NC	I/O	I/O
68	I/O	I/O	I/O
69	I/O	I/O	I/O
70	NC	I/O	I/O
71	I/O	I/O	I/O
72	I/O	I/O	I/O

## 144-Pin TQFP

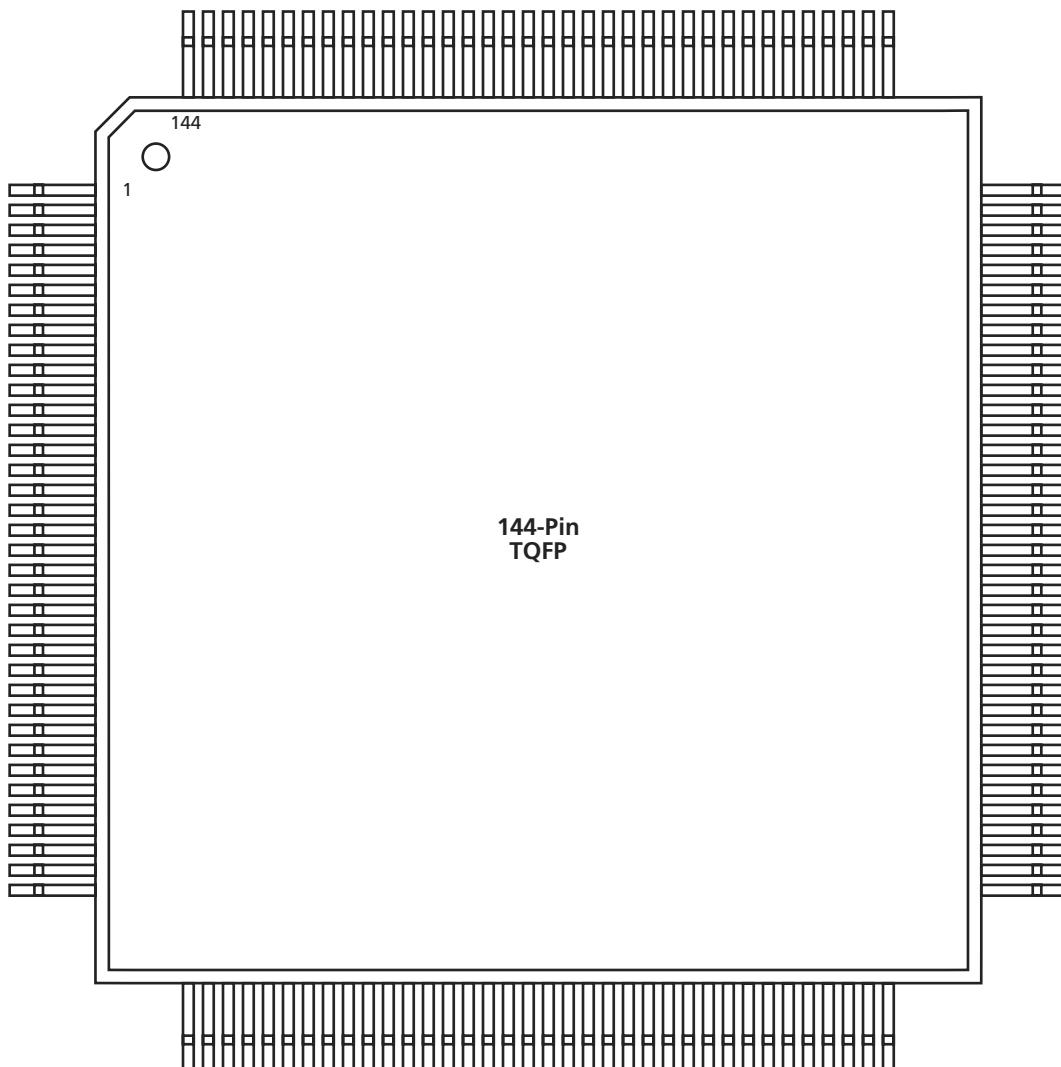


Figure 2-3 • 144-Pin TQFP (Top View)

### Note

For Package Manufacturing and Environmental information, visit the Package Resource center at <http://www.actel.com/products/rescenter/package/index.html>.

<b>176-Pin TQFP</b>			
<b>Pin Number</b>	<b>A54SX08 Function</b>	<b>A54SX16, A54SX16P Function</b>	<b>A54SX32 Function</b>
1	GND	GND	GND
2	TDI, I/O	TDI, I/O	TDI, I/O
3	NC	I/O	I/O
4	I/O	I/O	I/O
5	I/O	I/O	I/O
6	I/O	I/O	I/O
7	I/O	I/O	I/O
8	I/O	I/O	I/O
9	I/O	I/O	I/O
10	TMS	TMS	TMS
11	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
12	NC	I/O	I/O
13	I/O	I/O	I/O
14	I/O	I/O	I/O
15	I/O	I/O	I/O
16	I/O	I/O	I/O
17	I/O	I/O	I/O
18	I/O	I/O	I/O
19	I/O	I/O	I/O
20	I/O	I/O	I/O
21	GND	GND	GND
22	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
23	GND	GND	GND
24	I/O	I/O	I/O
25	I/O	I/O	I/O
26	I/O	I/O	I/O
27	I/O	I/O	I/O
28	I/O	I/O	I/O
29	I/O	I/O	I/O
30	I/O	I/O	I/O
31	I/O	I/O	I/O
32	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
33	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
34	I/O	I/O	I/O

<b>176-Pin TQFP</b>			
<b>Pin Number</b>	<b>A54SX08 Function</b>	<b>A54SX16, A54SX16P Function</b>	<b>A54SX32 Function</b>
35	I/O	I/O	I/O
36	I/O	I/O	I/O
37	I/O	I/O	I/O
38	I/O	I/O	I/O
39	I/O	I/O	I/O
40	NC	I/O	I/O
41	I/O	I/O	I/O
42	NC	I/O	I/O
43	I/O	I/O	I/O
44	GND	GND	GND
45	I/O	I/O	I/O
46	I/O	I/O	I/O
47	I/O	I/O	I/O
48	I/O	I/O	I/O
49	I/O	I/O	I/O
50	I/O	I/O	I/O
51	I/O	I/O	I/O
52	V <sub>CCI</sub>	V <sub>CCI</sub>	V <sub>CCI</sub>
53	I/O	I/O	I/O
54	NC	I/O	I/O
55	I/O	I/O	I/O
56	I/O	I/O	I/O
57	NC	I/O	I/O
58	I/O	I/O	I/O
59	I/O	I/O	I/O
60	I/O	I/O	I/O
61	I/O	I/O	I/O
62	I/O	I/O	I/O
63	I/O	I/O	I/O
64	PRB, I/O	PRB, I/O	PRB, I/O
65	GND	GND	GND
66	V <sub>CCA</sub>	V <sub>CCA</sub>	V <sub>CCA</sub>
67	V <sub>CCR</sub>	V <sub>CCR</sub>	V <sub>CCR</sub>
68	I/O	I/O	I/O

## 100-Pin VQFP

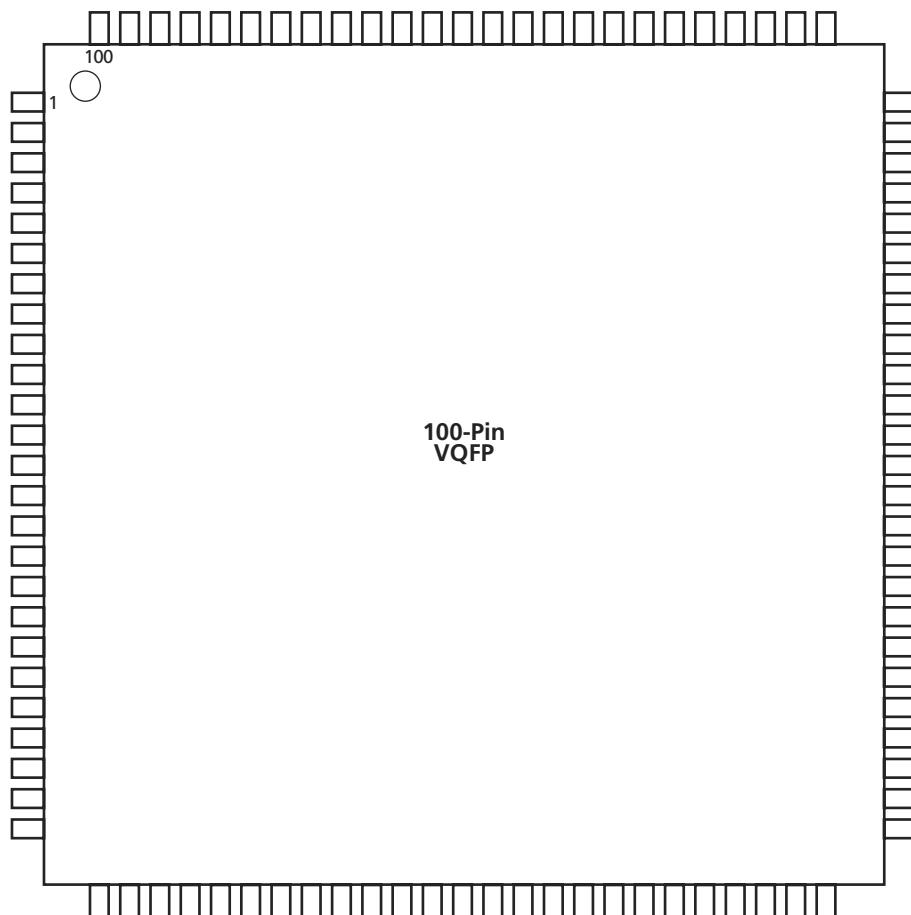


Figure 2-5 • 100-Pin VQFP (Top View)

### Note

For Package Manufacturing and Environmental information, visit the Package Resource center at <http://www.actel.com/products/rescenter/package/index.html>.

<b>313-Pin PBGA</b>	
<b>Pin Number</b>	<b>A54SX32 Function</b>
A1	GND
A3	NC
A5	I/O
A7	I/O
A9	I/O
A11	I/O
A13	V <sub>CCR</sub>
A15	I/O
A17	I/O
A19	I/O
A21	I/O
A23	NC
A25	GND
AA1	I/O
AA3	I/O
AA5	NC
AA7	I/O
AA9	NC
AA11	I/O
AA13	I/O
AA15	I/O
AA17	I/O
AA19	I/O
AA21	I/O
AA23	NC
AA25	I/O
AB2	NC
AB4	NC
AB6	I/O
AB8	I/O
AB10	I/O
AB12	I/O
AB14	I/O
AB16	I/O
AB18	V <sub>CCI</sub>
AB20	NC
AB22	I/O
AB24	I/O
AC1	I/O
AC3	I/O

<b>313-Pin PBGA</b>	
<b>Pin Number</b>	<b>A54SX32 Function</b>
AC5	I/O
AC7	I/O
AC9	I/O
AC11	I/O
AC13	V <sub>CCR</sub>
AC15	I/O
AC17	I/O
AC19	I/O
AC21	I/O
AC23	I/O
AC25	NC
AD2	GND
AD4	I/O
AD6	V <sub>CCI</sub>
AD8	I/O
AD10	I/O
AD12	PRB, I/O
AD14	I/O
AD16	I/O
AD18	I/O
AD20	I/O
AD22	NC
AD24	I/O
AE1	NC
AE3	I/O
AE5	I/O
AE7	I/O
AE9	I/O
AE11	I/O
AE13	V <sub>CCA</sub>
AE15	I/O
AE17	I/O
AE19	I/O
AE21	I/O
AE23	TDO, I/O
AE25	GND
B2	TCK, I/O
B4	I/O
B6	I/O
B8	I/O

<b>313-Pin PBGA</b>	
<b>Pin Number</b>	<b>A54SX32 Function</b>
B10	I/O
B12	I/O
B14	I/O
B16	I/O
B18	I/O
B20	I/O
B22	I/O
B24	I/O
C1	TDI, I/O
C3	I/O
C5	NC
C7	I/O
C9	I/O
C11	I/O
C13	V <sub>CCI</sub>
C15	I/O
C17	I/O
C19	V <sub>CCI</sub>
C21	I/O
C23	I/O
C25	NC
D2	I/O
D4	NC
D6	I/O
D8	I/O
D10	I/O
D12	I/O
D14	I/O
D16	I/O
D18	I/O
D20	I/O
D22	I/O
D24	NC
E1	I/O
E3	NC
E5	I/O
E7	I/O
E9	I/O
E11	I/O
E13	V <sub>CCA</sub>

<b>313-Pin PBGA</b>	
<b>Pin Number</b>	<b>A54SX32 Function</b>
E15	I/O
E17	I/O
E19	I/O
E21	I/O
E23	I/O
E25	I/O
F2	I/O
F4	I/O
F6	NC
F8	I/O
F10	NC
F12	I/O
F14	I/O
F16	NC
F18	I/O
F20	I/O
F22	I/O
F24	I/O
G1	I/O
G3	TMS
G5	I/O
G7	I/O
G9	V <sub>CCI</sub>
G11	I/O
G13	CLKB
G15	I/O
G17	I/O
G19	I/O
G21	I/O
G23	I/O
G25	I/O
H2	I/O
H4	I/O
H6	I/O
H8	I/O
H10	I/O
H12	PRA, I/O
H14	I/O
H16	I/O
H18	NC

<b>329-Pin PBGA</b>	
<b>Pin Number</b>	<b>A54SX32 Function</b>
T22	I/O
T23	I/O
U1	I/O
U2	I/O
U3	$V_{CCA}$
U4	I/O
U20	I/O
U21	$V_{CCA}$
U22	I/O
U23	I/O
V1	$V_{CCI}$
V2	I/O
V3	I/O

<b>329-Pin PBGA</b>	
<b>Pin Number</b>	<b>A54SX32 Function</b>
V4	I/O
V20	I/O
V21	I/O
V22	I/O
V23	I/O
W1	I/O
W2	I/O
W3	I/O
W4	I/O
W20	I/O
W21	I/O
W22	I/O

<b>329-Pin PBGA</b>	
<b>Pin Number</b>	<b>A54SX32 Function</b>
W23	NC
Y1	NC
Y2	I/O
Y3	I/O
Y4	GND
Y5	I/O
Y6	I/O
Y7	I/O
Y8	I/O
Y9	I/O
Y10	I/O
Y11	I/O

<b>329-Pin PBGA</b>	
<b>Pin Number</b>	<b>A54SX32 Function</b>
Y12	$V_{CCA}$
Y13	$V_{CCR}$
Y14	I/O
Y15	I/O
Y16	I/O
Y17	I/O
Y18	I/O
Y19	I/O
Y20	GND
Y21	I/O
Y22	I/O
Y23	I/O

<b>144-Pin FBGA</b>	
<b>Pin Number</b>	<b>A54SX08 Function</b>
A1	I/O
A2	I/O
A3	I/O
A4	I/O
A5	V <sub>CCA</sub>
A6	GND
A7	CLKA
A8	I/O
A9	I/O
A10	I/O
A11	I/O
A12	I/O
B1	I/O
B2	GND
B3	I/O
B4	I/O
B5	I/O
B6	I/O
B7	CLKB
B8	I/O
B9	I/O
B10	I/O
B11	GND
B12	I/O
C1	I/O
C2	I/O
C3	TCK, I/O
C4	I/O
C5	I/O
C6	PRA, I/O
C7	I/O
C8	I/O
C9	I/O
C10	I/O
C11	I/O
C12	I/O

<b>144-Pin FBGA</b>	
<b>Pin Number</b>	<b>A54SX08 Function</b>
D1	I/O
D2	V <sub>CCI</sub>
D3	TDI, I/O
D4	I/O
D5	I/O
D6	I/O
D7	I/O
D8	I/O
D9	I/O
D10	I/O
D11	I/O
D12	I/O
E1	I/O
E2	I/O
E3	I/O
E4	I/O
E5	TMS
E6	V <sub>CCI</sub>
E7	V <sub>CCI</sub>
E8	V <sub>CCI</sub>
E9	V <sub>CCA</sub>
E10	I/O
E11	GND
E12	I/O
F1	I/O
F2	I/O
F3	V <sub>CCR</sub>
F4	I/O
F5	GND
F6	GND
F7	GND
F8	V <sub>CCI</sub>
F9	I/O
F10	GND
F11	I/O
F12	I/O

<b>144-Pin FBGA</b>	
<b>Pin Number</b>	<b>A54SX08 Function</b>
G1	I/O
G2	GND
G3	I/O
G4	I/O
G5	GND
G6	GND
G7	GND
G8	V <sub>CCI</sub>
G9	I/O
G10	I/O
G11	I/O
G12	I/O
H1	I/O
H2	I/O
H3	I/O
H4	I/O
H5	V <sub>CCA</sub>
H6	V <sub>CCA</sub>
H7	V <sub>CCI</sub>
H8	V <sub>CCI</sub>
H9	V <sub>CCA</sub>
H10	I/O
H11	I/O
H12	V <sub>CCR</sub>
J1	I/O
J2	I/O
J3	I/O
J4	I/O
J5	I/O
J6	PRB, I/O
J7	I/O
J8	I/O
J9	I/O
J10	I/O
J11	I/O
J12	V <sub>CCA</sub>

<b>144-Pin FBGA</b>	
<b>Pin Number</b>	<b>A54SX08 Function</b>
K1	I/O
K2	I/O
K3	I/O
K4	I/O
K5	I/O
K6	I/O
K7	GND
K8	I/O
K9	I/O
K10	GND
K11	I/O
K12	I/O
L1	GND
L2	I/O
L3	I/O
L4	I/O
L5	I/O
L6	I/O
L7	HCLK
L8	I/O
L9	I/O
L10	I/O
L11	I/O
L12	I/O
M1	I/O
M2	I/O
M3	I/O
M4	I/O
M5	I/O
M6	I/O
M7	V <sub>CCA</sub>
M8	I/O
M9	I/O
M10	I/O
M11	TDO, I/O
M12	I/O

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